

Power Supply Design Seminar

Common Mistakes in DC/DC Converters and How to Fix Them

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Common Mistakes in DC/DC Converters and How to Fix Them

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Agenda

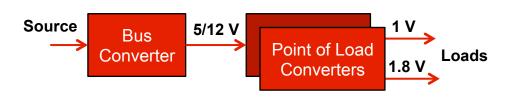
- Quick review
- 10 common mistakes and how to fix them
 - Converter capabilities and part selection
 - Component selection
 - Feature settings
 - Board layout
 - Measurement techniques
- Summary

"Learn from the mistakes of others. You can't live long enough to make them all yourself."

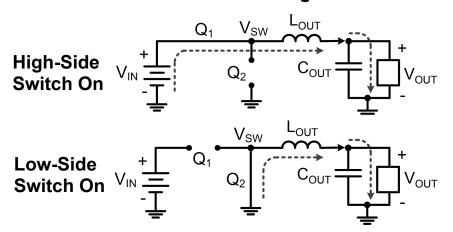
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Quick Review

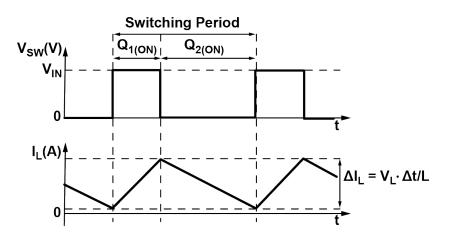
- DC/DC converters used as point-ofload voltage regulators
- Buck converter is most common topology



Buck Converter Switching States

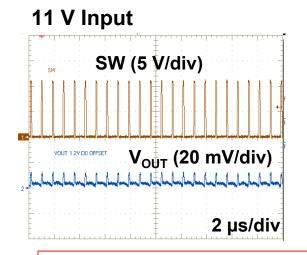


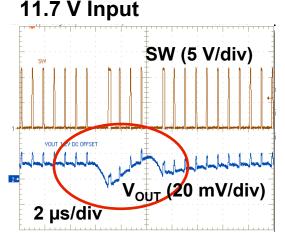
Steady State Waveforms



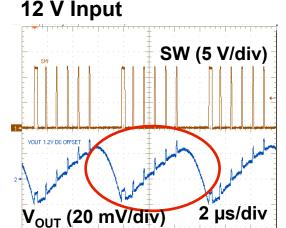
1) Why Are There Jumps in the Output Voltage?

Conditions: 1.2 V/0 A output, switching frequency (f_{SW}) = 1.2 MHz, Forced continuous conduction mode (FCCM)





High-side switch **minimum on-time** (t_{ON}) **violation** cannot output narrow enough SW node pulses



$$t_{ON} = \frac{1}{f_{SW}} \cdot \frac{V_{OUT}}{V_{IN}}$$
$$t_{ON} = 83 \text{ ns}$$

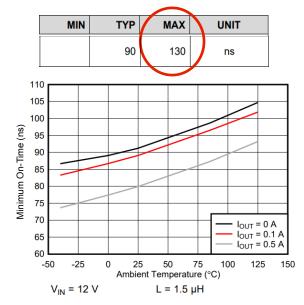
1) Duty-Cycle Limits Considerations

- Select switching frequency (f_{SW}) based on:
 - Maximum minimum on-time
 - Maximum input voltage

$$f_{SW} \le \frac{1}{t_{ON(MIN)}} \cdot \frac{V_{OUT}}{V_{I(MAX)}}$$

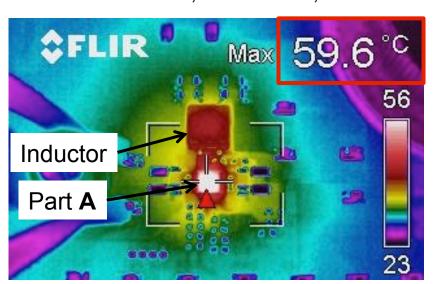
- If min on-time is violated converters will either:
 - Skip pulses
 - Change switching frequency
 - Output will become unregulated

 Minimum on-time varies with temperature, with load and from part to part

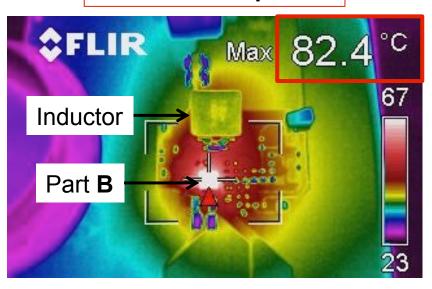


2) Which Part Is Rated for 8 A?

Conditions: 12 V, 1.8 V at 8 A, 700 kHz



Both are 8 A parts!

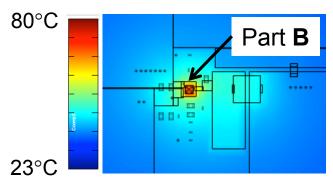


Part B gets over 20°C hotter and has a larger thermal footprint
Part B has little margin if 85°C ambient temperature due to 60°C temperature rise

2) Thermal Derating - Part Comparison

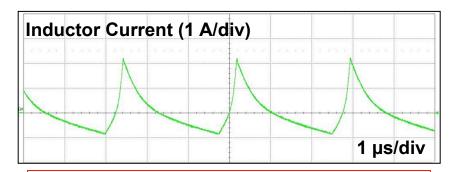
Spec	Part A (TPS54824)	Part B (TPS54821)
V _{IN} range	4.5 – 17 V	4.5 – 17 V
Current	8 A	8 A
Size	3.5 x 3.5 mm	3.5 x 3.5 mm
R _{DS(ON)}	14/6 mΩ	26/19 mΩ
Modeled P _{LOSS}	1.69 W	2.38 W
Simulated die temp	64 °C	81 °C
Price	\$\$	\$

- Part B can be used if 8 A is a short transient condition or low ambient temp
- Consider average current for thermals
- TI's WebTHERM[™] online tool estimates thermal performance on EVMs

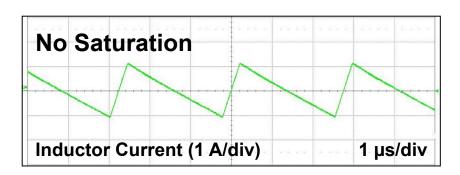


Part B Thermal Simulation Result

3A) What's Wrong with the Inductor Current?

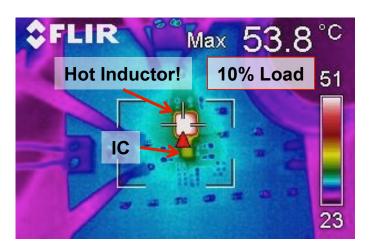


Inductor Current Saturation!



- Inductor current slope sharply increases when core saturates
 - Saturation → low core permeability
 - Causes peaking in current waveform of hard saturating cores
- Saturation can cause problems
 - Can damage converter
 - Leads to premature overcurrent protection
 - Limits converter output current
- Consider using an inductor with a soft saturating core

3B) Why Is the Inductor so Hot?



L = 240 nH \rightarrow large inductor current ripple (ΔI_L)! (over 100%)

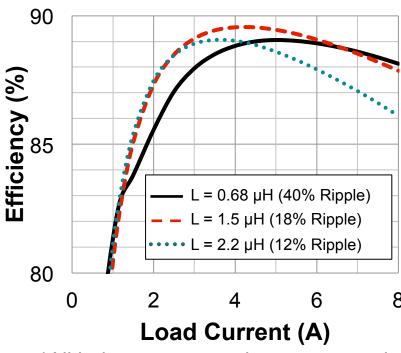


L = 1 μ H, has ~30% ripple

$$P_{CORE} \approx k_0 f_{SW} B_{PK}^2 \propto k_0 f_{SW} \Delta I_L^2$$

High core loss due to low inductance and high current ripple

3) Inductor Selection Guidelines



*All inductors: same size, same vendor

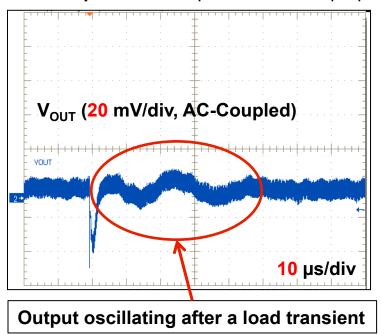
 Rule of thumb: current ripple between 15% and 40% of max load current

$$L = \left(\frac{V_{IN(MAX)} - V_{OUT}}{K \cdot I_{OUT}}\right) \left(\frac{V_{OUT}}{V_{IN(MAX)} \cdot f_{SW}}\right)$$

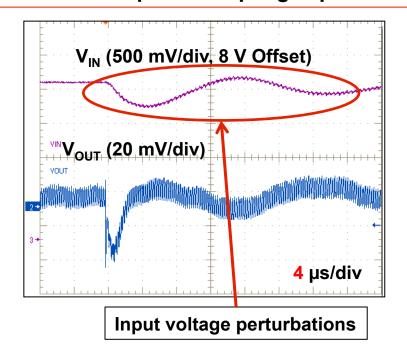
- For converters, use rated load current of device
- Higher inductance tends to increase peak efficiency
 - Lower core loss/RMS currents
 - Slower transient response
- Lower inductance has higher full load efficiency
 - Lower winding resistance

4A) What's Causing the Output Oscillation?

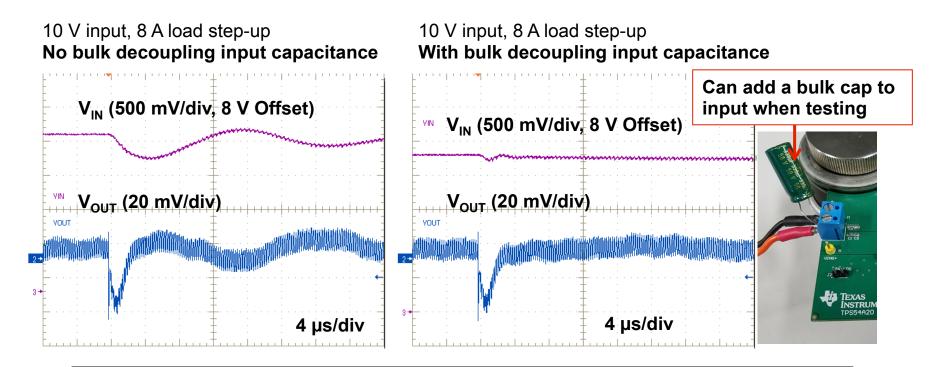
10 V input, 1.2 V output, 8 A load step-up



Insufficient input decoupling capacitance!

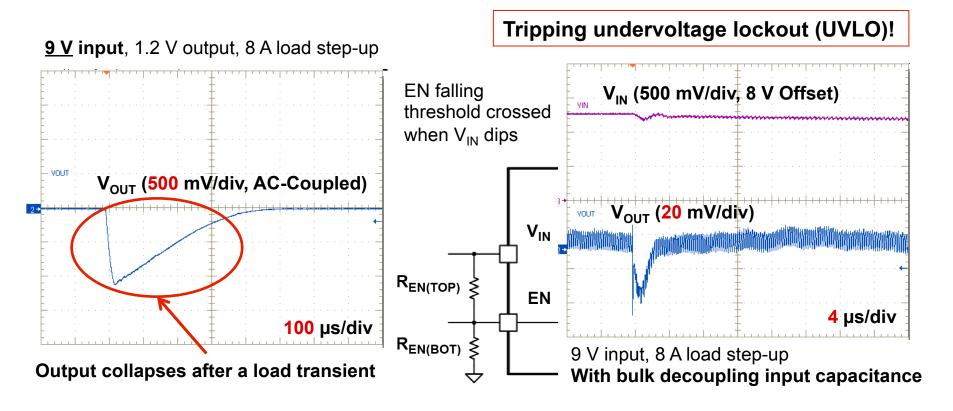


4A) Input Capacitance Comparison



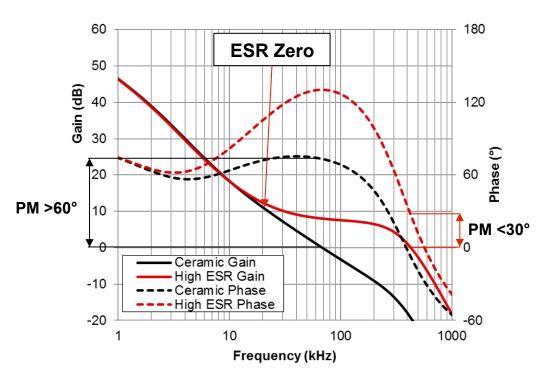
Ensure bus converter is designed correctly to handle large load transients

4B) Why Does the Output Voltage Collapse?



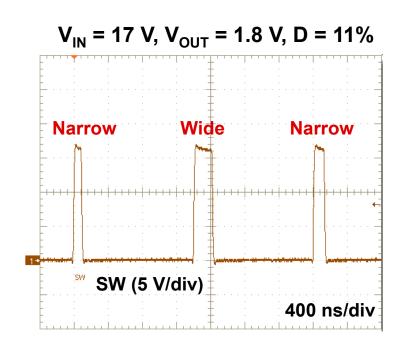
4) Input/Output Capacitor Guidelines

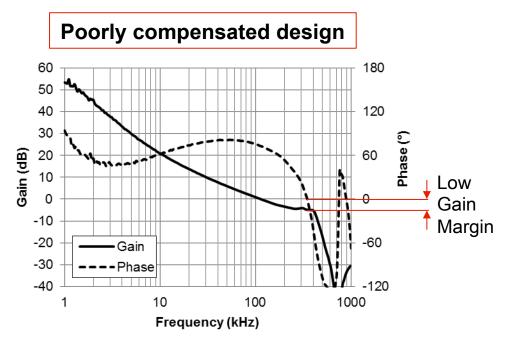
- Ensure sufficient decoupling capacitance
- Don't replace a low ESR cap with a "cheap" high ESR cap
 - Can cause instability!
 - ESR increases by factor
 4 to 15 at -40 °C!
- Select output capacitance with load transient requirements accounted for
- Check RMS current rating



Different compensation is needed!

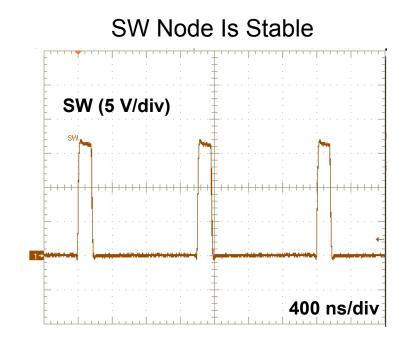
5A) What Caused Wide/Narrow SW Node Pulses?

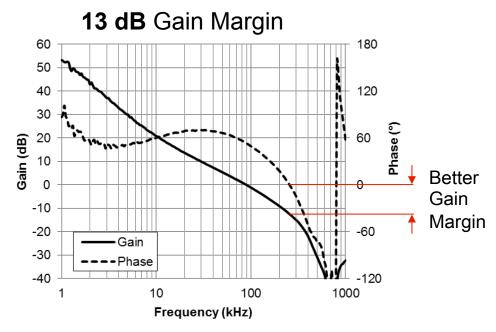




Low gain margin! <5 dB! (Gain when phase crosses 0)

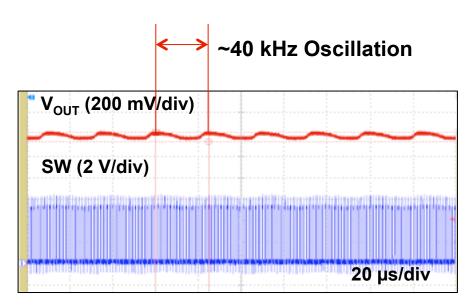
5A) Design for More Gain Margin





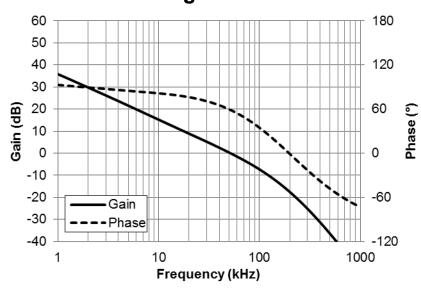
Design rule of thumb: >10 dB gain margin (across ALL operating conditions)

5B) Why Is the Output Oscillating?



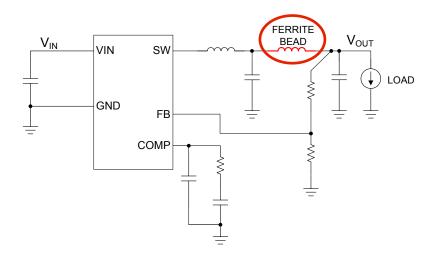
Design is stable on an EVM but output oscillates in real application

Phase Margin: 60° Gain Margin: 16.7 dB

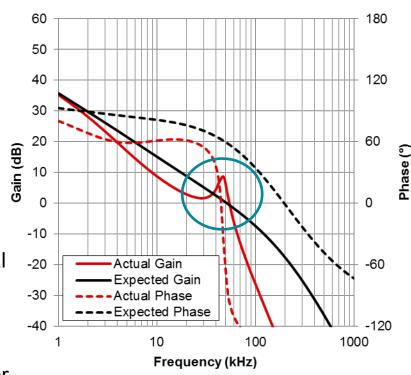


Simulation shows sufficient phase margin and gain margin

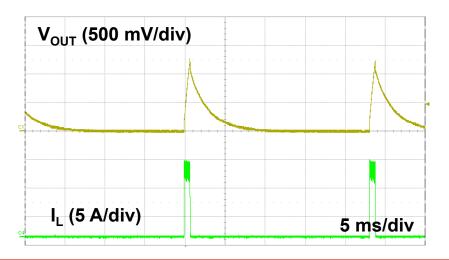
5B) Compensate for System Level Output Filter



- Second stage LC filter not included in original design and causes instability!
 - Resonance frequency is ~40 kHz
 - Same frequency as oscillation
- Design compensation for the actual output filter



6) Why Doesn't the Converter Start Up?



A very **large output capacitance** is causing the converter to hit its **overcurrent limit** during startup. The hiccup auto-restart process continues indefinitely.

6) Pick an Appropriate Soft Start Time

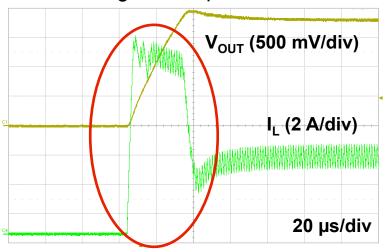
- Avoid input voltage sag due to inrush current
- Estimate converter input and output current

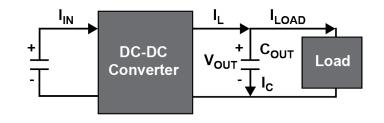
$$I_C = C \frac{\Delta V}{\Delta T} \qquad \qquad \bigvee_{\text{OUT}} \qquad \qquad \bigvee_{\text{Tss}} \qquad \Delta V_{\text{OUT}}$$

$$I_L = I_{LOAD} + I_C \qquad \qquad \bigvee_{\text{I}_{IN}} \Delta V_{\text{OUT}}$$

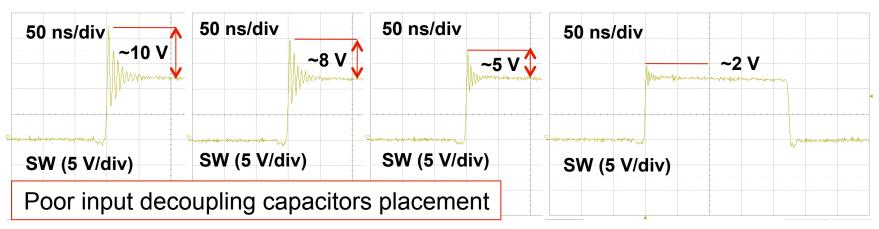
- Avoid overcurrent protection limit
- Sequence startup of supply rails

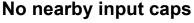
Current surge: startup time is too short





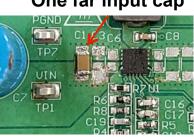
7) Why Is There Large SW Node Ringing?







One far input cap



10 μF, 1206

Two close caps



10 μF, 1206 0.1 μF, 0603

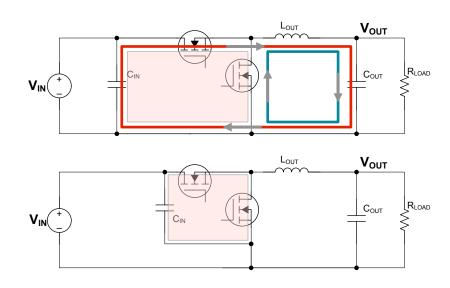
Two-sided, close caps



2 x 10 µF, 1206 2 x 0.1 µF, 0603

7) Understand Layout Parasitics

- Minimize loop area and keep components close
- Optimize grounding/return paths
- Avoid large SW node → EMI
- Keep noise sensitive analog pins/ traces (e.g. FB, COMP) away from noisy power pins/traces (e.g. SW, BOOT)
- Can add a snubber or a boot resistor to control/slow down SW node slew rate

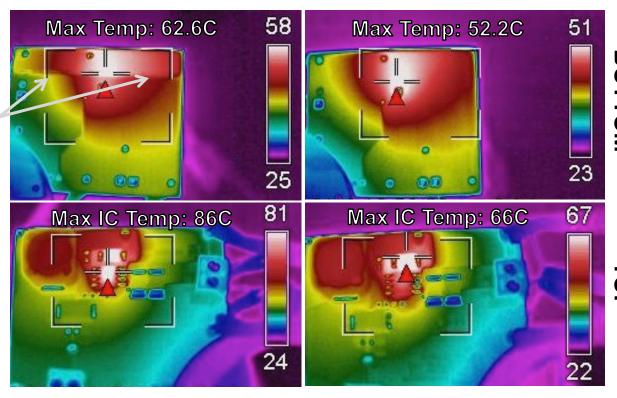


Board A

Board B

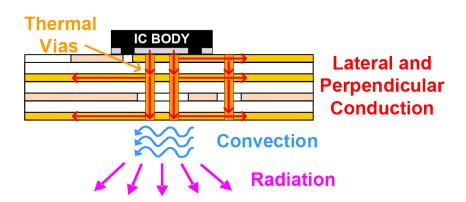
Traces cutting through the ground plane

- Traces on the bottom layer prevent heat from spreading effectively
- Removing horizontal trace for a more solid bottom layer reduces IC temp on Board B
- Hottest component on B is the catch diode



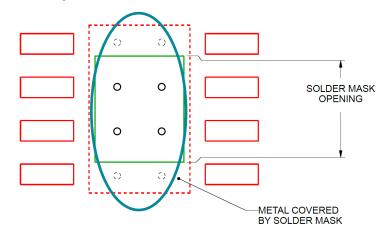
8) Layout PCB Considering Thermals

- Have solid ground planes to better spread heat across the layer
- Use thermal vias to spread heat to other layers



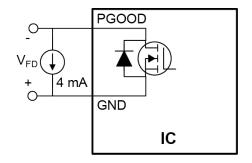
 Thermal pads help to get the heat out of the IC into the PCB

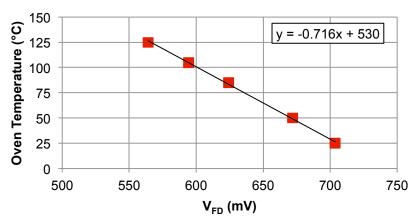
Footprint with Thermal Via Pattern



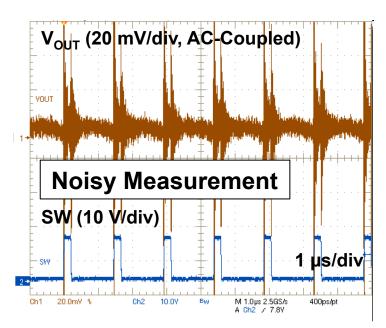
8) In Situ Junction Temperature Measurement

- Common question: How much thermal margin is there in my design?
- Difficult to accurately measure IC junction temp in operation
- One option: Use the internal diode on PGOOD or similar pin
 - First characterize diode voltage versus temperature
 - Measure diode voltage in operation
 - View <u>app note slva397</u> for more details

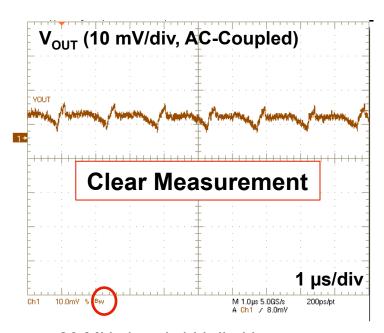




9) Which Output Measurement Is Right?



- Switching noise picked up from channel 2
- No bandwidth limiting



- 20 MHz bandwidth limiting
- Switch node probe removed

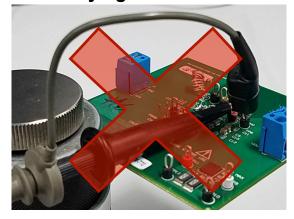
9) Correct Measurement Techniques

- Measure right across the output capacitor
 - Use a "tip and barrel" approach
 - Probe sockets for prototypes
 - Don't have a flying ground lead
- Limit the bandwidth 20 MHz
- Use scope full Y-axis scale
- Consider 1:1 probes or active probes

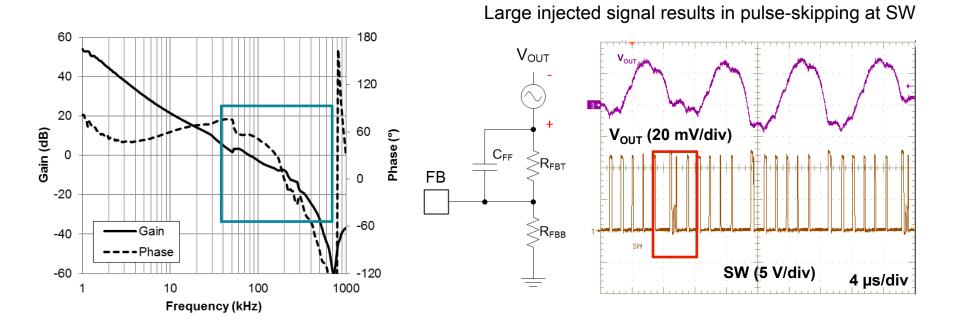
"Tip and Barrel"



Flying Ground Lead

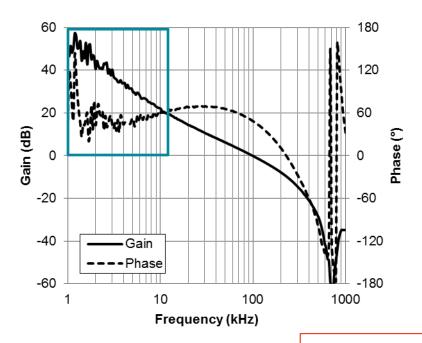


10A) Why Is the Bode Plot Not Smooth?



Signal injection too large

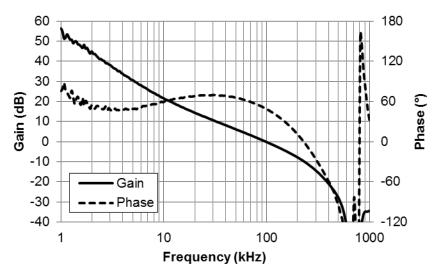
10B) Why Is the Bode Plot Not Smooth?



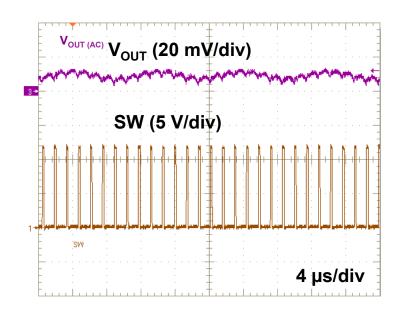
- Signal-to-noise ratio is too low to make an accurate measurement
- At low frequencies, gain of loop attenuates injected signal
- Increasing integration time or using lower frequency IF bandwidth helps to filter noise

Signal injection too small

10) Optimal Small Signal Injection



- Too large → glitches at higher frequency
- Too small → inaccurate measurement
- Shape injected signal amplitude vs frequency



Good measurement: visible oscillation on V_{OUT} and SW waveform is stable

Summary

- Reviewed common mistakes in point of load DC/DC converters
 - Minimum on-time limitation and converter ratings
 - Inductor and capacitor selection
 - Compensation and startup
 - Converter PCB layout to minimize parasitics and improve thermal dissipation
 - Output voltage and bode plot measurement techniques
- Explained why these mistakes occur and how to avoid them
- Use this presentation as a reference when debugging and working on new designs

References

- Switch-mode power converter compensation made easy https://www.ti.com/seclit/ml/slup340/slup340.pdf
- Power Tips: Designing a two-stage LC filter
 https://e2e.ti.com/blogs_/b/powerhouse/archive/2015/02/24/power-tips-designing-a-two-stage-lc-filter
- Junction temperature measurement <u>http://www.ti.com/lit/an/slva397/slva397.pdf</u>
- Parts used in presentation
 - http://www.ti.com/product/TPS54824
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